

**Search Notes**

Application/Control No.

10/673,636

Examiner

Khai M. Nguyen

Applicant(s)/Patent under  
Reexamination

VACON ET AL.

Art Unit

2687

**SEARCHED**

Class	Subclass	Date	Examiner
455	435.2 435.1 422.1 453 450	7/2/2005	KN
455	452.1	7/2/2005	KN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR